

HOLOGRAM LASER

LT0H34P

Hologram Laser(3 beam) for MD players/recorders

■ Features

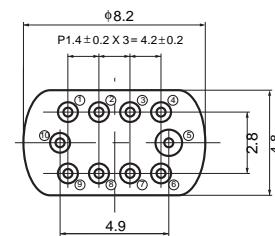
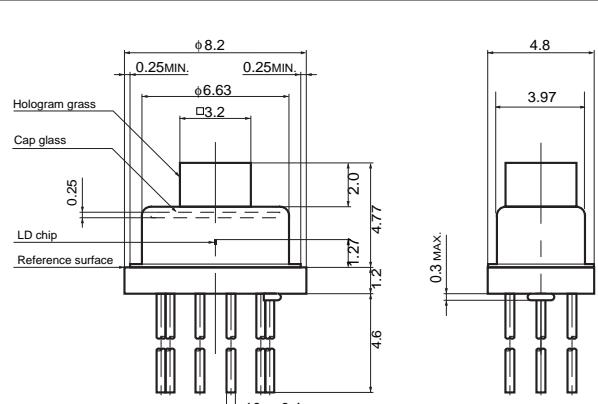
- (1) Compact package with high power output (MAX. 35mW)
- (2) Enables to design compact pick-up thanks to compact package. (Thickness; 4.8mm)
- (3) Since its semiconductor laser, signal detection photocell, and circuit array are assembled in a package, the optical pick is simple in assembling and adjustment
- (4) The adjustment during pickup assembly is eased and can easily be automated.

■ Applications

- (1) MD players/recorders

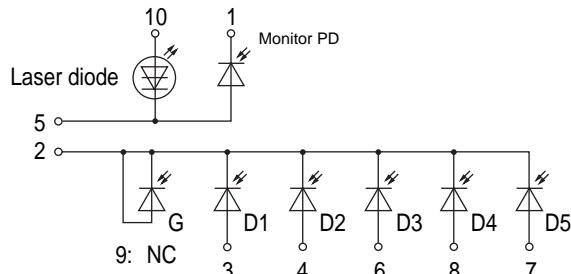
■ Outline Dimensions

(Unit: mm)



[Terminal connection]

LT0H34P



■ Absolute Maximum Ratings

Parameter	Symbol	Ratings	Units
Optical power output *1	P _H	32	mW
Reverse voltage	V _R	2	V
Laser		30	
Monitor photodiode		15	
Photodiode for signal detection			
Operating temperature *2	Toopr	-10 to +60	°C
Storage temperature *2	Tstg	-40 to +85	°C
Soldering temperature *3	Tsol	260(5s or less)	°C

(Notice)

- In the absence of device specification sheets, SHARP takes no responsibility for any defects that may occur in equipment using any SHARP devices shown in catalogs, data books, etc. Contact SHARP in order to obtain the latest device specification sheets before using any SHARP device.

- Specifications are subject to change without notice for improvement.

(Internet)

- Data for Sharp's optoelectronic/power devices is provided for internet. (Address <http://www.sharp.co.jp/ecg/>)

*1 Output power from hologram laser

*2 Case temperature

*3 At the position of 1.6mm from the bottom face of resin package.

LTOH34P

■ Electro-optical Characteristics

(Tc=25°C)

Parameter			Symbol	Condition	MIN	TYP	MAX	Units	
Laser	Threshold current	Ith		-	-	60	80	mA	
	Operating current	Iop		P _H =27.4mW *1	-	125	150	mA	
	Operating voltage	Vop			-	1.8	2.2	V	
	Wavelength *2	λp			770	785	800	nm	
	Monitor current	Im	P _H =27.4mW *1, V _R =5V		-	0.14	-	mA	
	Radiation Characteristics	Angle	θ _{//}		-	11	-	°	
			θ _⊥		-	26	-	°	
	Emission Point accuracy	Angle	Δφ _{//}	P _H =27.4mW *1	-	-	±1	°	
			Δφ _⊥		-	-	±3	°	
		Position	Δx		-	-	±30	μm	
			Δy		-	-	±30	μm	
			Δz		-	-	±80	μm	
Monitor Photodiode	Differential efficiency	η	18.3mW Iop(27.4mW) - Iop(9.1mW)		0.25	0.5	0.85	mW/mA	
	Dark current	Id	V _R =5V		-	-	150	nA	
	Terminal capacitance	Ct			-	20	-	pF	
Photodiode for signal detection	Reverse voltage		V _R	I _R =10μA	A				
					B	15	-	V	
					C	-	-		
	Dark current		Id	V _R =1.5V	A				
					B	-	-	nA	
					C	-	-		
	Terminal capacitance		Ct	V _R =1.5V,f=1MHz	A	1.0	-	pF	
					B	0.6	-		
					C	-	-		
	Short circuit current *3 *4		Isc	Ev=1000Lx	A	120	210		
					B	40	80		
					C	60	115		
	Response time *5		tr,tf	V _R =1.5V, R _L =180Ω	A	-	-	ns	
					B	-	-		
					C	-	-		

*1 Output power form LD chip

*7 Applicable divisions

*2 Oscillation mode: TEM₀₀

correspond to pattern segment No.

*3 Values in each element. Elements other than subject elements shall be measured while the anode and the cathode are short-circuited to each other

D1	D2	D3	D4

*4 Short-circuit currents between segments D1 and D5 or D3 and D4 shall be within ±10% of the average

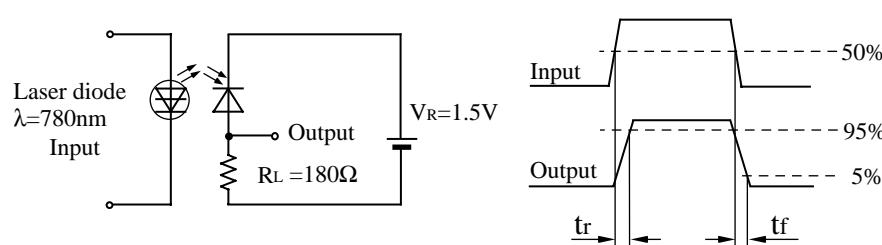
Segment No.

D1,D5 A
D2,D3 B
D4 C

*5 Ev:Illuminance by CIE standard light source A(tungsten lamp)

Fig.1

*6 Measuring method is shown below.



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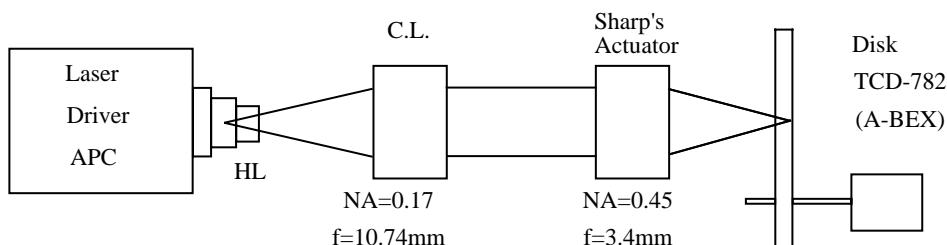
■ Electro-optical Characteristics *1

(Tc=25°C)

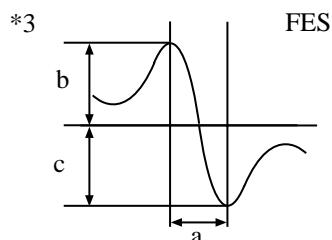
Parameter	Condition	MIN	TYP	MAX	Units
Focus error signal offsetting *2	Values at FES output amplitude 5μAp-p	-0.4	0	+0.4	μm
Lead-in for focus error signal *3		10	19	30	μm
RF Output amplitude (D2+D3+D4)*4		5	10	-	μA p-p
RES Output amplitude (D1-D5) *5		0.3	0.55	1.0	μA p-p
Radial error balance *6		-20	-	20	%

D1,D2,D3,D4,D5: Refer to pattern segment No. (Fig.1)

*1 Measuring method is shown below.

Measuring method of electro-optical characteristics

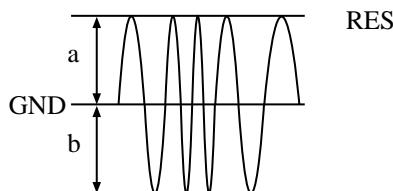
*2 Distance between FES=0 and jitter Min. point



*4 Focus/radial servo is ON-state

*5 RES output amplitude: under the condition that only focus servo is effected

$$*6 \frac{(a - b) / 2}{a + b}$$



Factors *2 to *6 are measured with high-reflection disk
(TCD782 made by A-BEX) at 3μAp-p of FES output amplitude
3μAp-p of the FES output amplitude is set through focusing oscillation